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(PTO-1449)

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New U.S. Patent
Application 10/782784APPLICANT(S)
Jong-Hyuk BAEK

CUSTOMER NO. 34610

FILING DATE
February 23, 2004GROUP
To be assigned

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
CZL	6,404,292	06/11/2002	LAUTZENHISER	331	17	

U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	

U.S. PATENT APPLICATIONS

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
CZL	WO 01/61857 A2	08/23/2001	PCT				
CZL	2002-111492	04/12/2002	JAPAN			Abstract	
CZL	EP 1 223 676 A2	07/17/2002	EUROPE				
	2002-0066925	08/21/2002	KOREA				X

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

EXAMINER	Cassandra Cox	DATE CONSIDERED	March 31, 2005
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